

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/846,207	TAN ET AL.
Examiner	Art Unit	
Nhon T. Diep	2621	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<p>Interference Search History</p> <p>Print-out 7/27/06 N.D.</p>			